

IGBT – Power, Co-PAK N-Channel, Field Stop VII (FS7), Non-SCR, TO247-3L 1200 V, 1.7 V, 140 A

FGY140T120SWD

Description

Using the novel field stop 7th generation IGBT technology and the Gen7 Diode in TO247 3-lead package, FGY140T120SWD offers the optimum performance with low switching and conduction losses for high-efficiency operations in various applications like Solar, UPS, and ESS.

Features

- Maximum Junction Temperature $T_J = 175^{\circ}C$
- Positive Temperature Coefficient for Easy Parallel Operation
- High Current Capability
- Smooth and Optimized Switching
- Low Switching Loss
- RoHS Compliant

Applications

- Boost and Inverter in Solar System
- UPS
- Energy Storage System

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Symbol	Value	Unit	
Collector-to-Emitter Volt	Collector-to-Emitter Voltage		1200	V
Gate-to-Emitter Voltage		V_{GES}	±20	
Transient Gate-to-Emitte	er Voltage		±30	
Collector Current	Collector Current $T_C = 25^{\circ}C(Note 1)$		280	Α
	T _C = 100°C		140	
Power Dissipation	T _C = 25°C	P_{D}	1153	W
	T _C = 100°C		576	
Pulsed Collector Current	$T_C = 25^{\circ}C,$ $t_p = 10 \ \mu s \ (Note \ 2)$	I _{CM}	560	Α
Diode Forward	T _C = 25°C	I _F	280	
Current	T _C = 100°C	1	140	
Pulsed Diode Forward Current	O ,		560	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55 to +175	°C
Lead Temperature for So	TL	260		

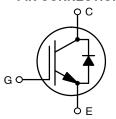
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

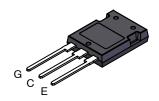
1

- 1. Value limited by bond wire
- 2. Repetitive rating: Pulse width limited by max. junction temperature.

BV _{CES}	V _{CE(SAT)}	lc
1200 V	1.7 V	140 A

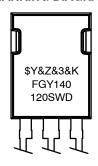
PIN CONNECTIONS





TO-247-3LD CASE 340CD

MARKING DIAGRAM



\$Y = onsemi Logo &Z = Assembly Plant Code &3 = 3-Digit Date Code &K = 2-Digit Lot Traceability Code FGY140120SWD = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
FGY140T120SWD	TO-247-3LD (Pb-Free)	30 Units / Tube

THERMAL CHARACTERISTICS

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case for IGBT	$R_{\theta JC}$	0.13	°C/W
Thermal Resistance, Junction-to-Case for Diode		0.23	
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	40	

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) Parameter Symbol Test Conditions Min Typ Max Unit

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Collector-to-Emitter Breakdown Voltage	BV _{CES}	$V_{GE} = 0 \text{ V}, I_C = 5 \text{ mA}$	1200	-	-	V
Breakdown Voltage Temperature Coefficient	ΔBV_CES	$V_{GE} = 0 \text{ V, } I_{C} = 5 \text{ mA}$	-	1226	-	mV/°C
	ΔT_{J}					
Collector-to-Emitter Cut-Off Current	I _{CES}	V _{GE} = 0 V, V _{CE} = V _{CES}	-	-	40	μΑ
Gate-to-Emitter Leakage Current	I _{GES}	V _{GE} = 20 V, V _{CE} = 0 V	-	-	±400	nA
ON CHARACTERISTICS						
Gate-to-Emitter Threshold Voltage	V _{GE(th)}	$V_{GE} = V_{CE}$, $I_{C} = 140$ mA, $T_{J} = 25^{\circ}C$	5.60	6.54	7.40	V
Collector-to-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} = 15 V, I _C = 140 A, T _J = 25°C	1.35	1.7	2.0]
		V _{GE} = 15 V, I _C = 140 A, T _J = 175°C	-	2.25	-]
DYNAMIC CHARACTERISTICS						
Input Capacitance	C _{ies}	V _{CE} = 30 V, V _{GE} = 0 V, f = 1 MHz	-	13395.0	-	pF
Output Capacitance	C _{oes}		-	394	-	1
Reverse Transfer Capacitance	C _{res}	1	-	55.4	-]
Total Gate Charge	Q_g	V _{CE} = 600 V, V _{GE} = 15 V, I _C = 140 A	-	415.4	-	nC
Gate-to-Emitter Charge	Q _{ge}		-	104.8	-	
Gate-to-Collector Charge	Q_{gc}		-	154.8	-	
SWITCHING CHARACTERISTICS						
Turn-on Delay Time	t _{d(on)}	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}$ $I_{C} = 70 \text{ A R}_{G} = 4.7 \Omega \text{ T}_{J} = 25^{\circ}\text{C}$	-	55.2	-	ns
Turn-off Delay Time	t _{d(off)}	$I_{\rm C} = 70 \text{ A R}_{\rm G} = 4.7 \Omega I_{\rm J} = 25^{\circ}{\rm C}$	-	249.6	-]
Rise Time	t _r		-	43.2	-	1
Fall Time	t _f		-	65.6	-]
Turn-on Switching Loss	E _{on}		-	4.7	-	mJ
Turn-off Switching Loss	E _{off}		-	2.3	-	1
Total Switching Loss	E _{ts}		-	6.9	-]
Turn-on Delay Time	t _{d(on)}	V _{CE} = 600 V, V _{GE} = 15 V	-	59.2	-	ns
Turn-off Delay Time	t _{d(off)}	$I_C = 140 \text{ A R}_G = 4.7 \Omega \text{ T}_J = 25^{\circ}\text{C}$	-	227.2	-]
Rise Time	t _r		-	97.6	-]
Fall Time	t _f		-	67.2	-	1
Turn-on Switching Loss	E _{on}		-	12.5	-	mJ
Turn-off Switching Loss	E _{off}]	-	5.1	-	
Total Switching Loss	E _{ts}	1	-	17.6	-	1

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted) (continued)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS						•
Turn-on Delay Time	t _{d(on)}	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V}$ $I_C = 70 \text{ A R}_G = 4.7 \Omega \text{ T}_J = 175^{\circ}\text{C}$	_	48.0	-	ns
Turn-off Delay Time	t _{d(off)}		-	284.8	-	1
Rise Time	t _r		-	41.6	-	1
Fall Time	t _f		-	96.0	-	1
Turn-on Switching Loss	E _{on}		-	7.5	-	mJ
Turn-off Switching Loss	E _{off}		-	3.1	-	1
Total Switching Loss	E _{ts}		-	10.6	-	1
Turn-on Delay Time	t _{d(on)}	V _{CE} = 600 V, V _{GE} = 15 V	-	52.8	-	ns
Turn-off Delay Time	t _{d(off)}	$I_C = 140 \text{ A R}_G = 4.7 \Omega \text{ T}_J = 175^{\circ}\text{C}$	-	264.0	-	1
Rise Time	t _r		-	92.8	-	1
Fall Time	t _f	1	_	113.6	_	1
Turn-on Switching Loss	E _{on}	1	_	17.1	_	mJ
Turn-off Switching Loss	E _{off}	1	-	7.4	-	
Total Switching Loss	E _{ts}		_	24.5	-	
DIODE CHARACTERISTICS						
Forward Voltage	V _F	I _F = 140 A, T _J = 25°C	1.73	1.95	2.33	V
		I _F = 140 A, T _J = 175°C	-	2.15	-	
DIODE SWITCHING CHARACTERISTIC	S, INDUCTIVE LO	AD				
Reverse Recovery Time	t _{rr}	$V_R = 600 \text{ V, I}_F = 70 \text{ A,}$ $dI_F/dt = 1000 \text{ A/}\mu\text{s, T}_J = 25^{\circ}\text{C}$	-	219.4	-	ns
Reverse Recovery Charge	Q _{rr}		-	4507.9	-	nC
Reverse Recovery Energy	E _{REC}		-	1.6	-	mJ
Peak Reverse Recovery Current	I _{RRM}		-	41.1	-	Α
Reverse Recovery Time	t _{rr}	V _R = 600 V, I _F = 140 A,	-	307.3	1	ns
Reverse Recovery Charge	Q _{rr}	- dl _F /dt = 1000 A/μs, T _J = 25°C	-	7047.2	-	nC
Reverse Recovery Energy	E _{REC}		-	2.7	1	mJ
Peak Reverse Recovery Current	I _{RRM}		-	45.9	1	Α
Reverse Recovery Time	t _{rr}	V _R = 600 V, I _F = 70 A,	-	425.3	1	ns
Reverse Recovery Charge	Q _{rr}	- dl _F /dt = 1000 A/μs, T _J = 175°C	-	13076.8	-	nC
Reverse Recovery Energy	E _{REC}			5.5	-	mJ
Peak Reverse Recovery Current	I _{RRM}	1	_	61.5	ĺ	Α
Reverse Recovery Time	t _{rr}	V _R = 600 V, I _F = 140 A,	-	516.5	-	ns
Reverse Recovery Charge	Q _{rr}	$dI_F/dt = 1000 \text{ A/}\mu\text{s}, T_J = 175^{\circ}\text{C}$	_	18736.9	-	nC
	i i	-		7.0		m l
Reverse Recovery Energy	E _{REC}		_	7.6	_	mJ

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

TYPICAL CHARACTERISTICS

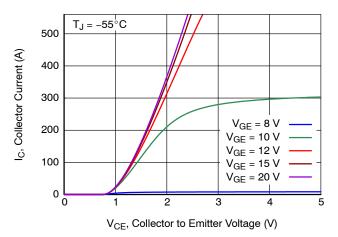


Figure 1. Output Characteristics

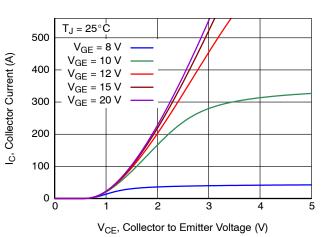


Figure 2. Output Characteristics

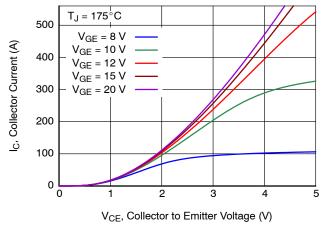


Figure 3. Output Characteristics

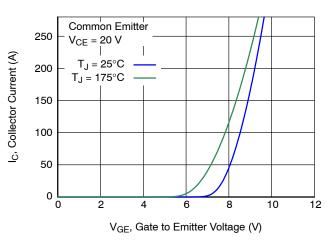


Figure 4. Transfer Characteristics

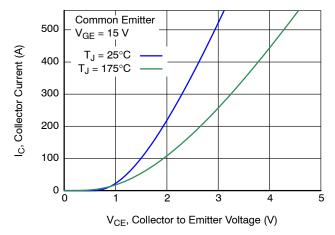


Figure 5. Saturation Characteristics

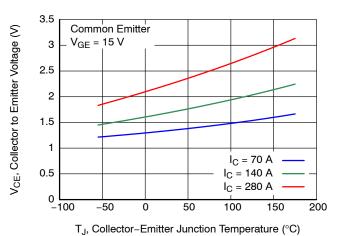


Figure 6. Saturation Voltage vs. Junction Temperature

TYPICAL CHARACTERISTICS

 V_{GE} , Gate to Emitter Voltage (V)

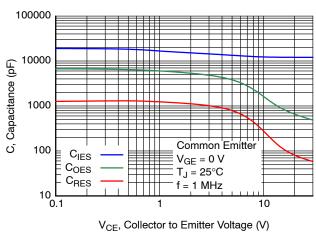


Figure 7. Capacitance Characteristics

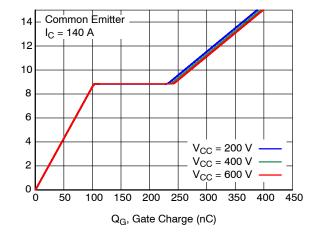


Figure 8. Gate Charge Characteristics

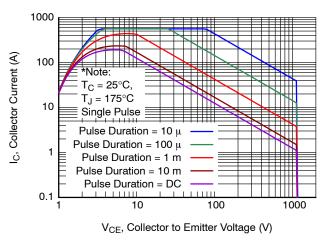


Figure 9. SOA Characteristics

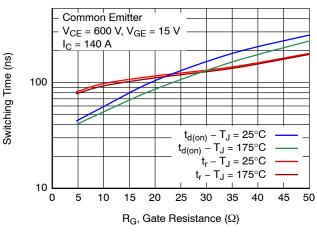


Figure 10. Turn-on Switching Time vs. Gate Resistance

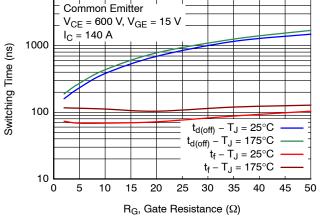


Figure 11. Turn-Off Switching Time vs. Gate Resistance

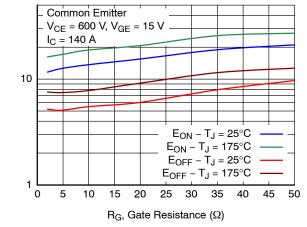


Figure 12. Switching Loss vs. Gate Resistance

Switching Loss (mJ)

TYPICAL CHARACTERISTICS

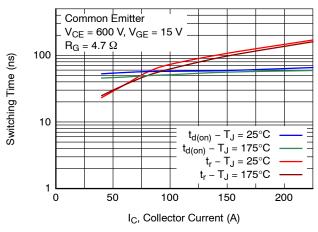


Figure 13. Turn-On Switching Time vs.
Collector Current

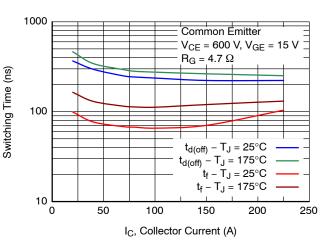


Figure 14. Turn-Off Switching Time vs.
Collector Current

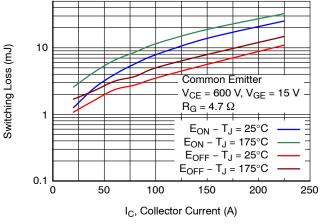


Figure 15. Turn-On Switching Loss vs. Collector Current

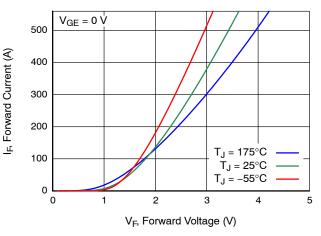


Figure 16. Diode Forward Characteristics

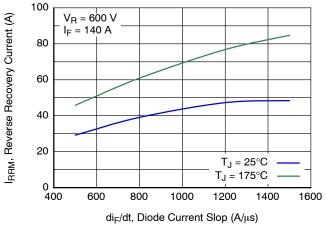


Figure 17. Diode Reverse Recovery Current

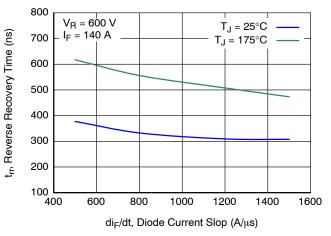


Figure 18. Diode Reverse Recovery Time

TYPICAL CHARACTERISTICS

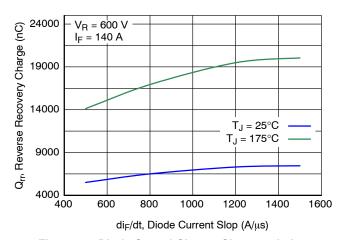


Figure 19. Diode Stored Charge Characteristics

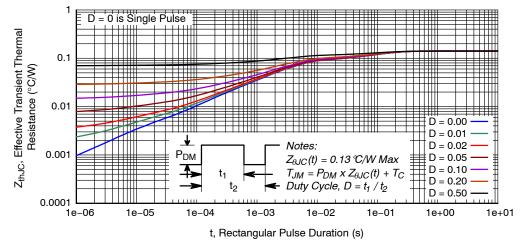


Figure 20. Transient Thermal Impedance of IGBT

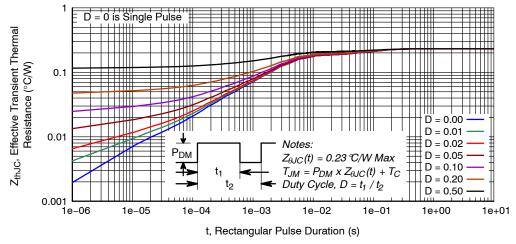


Figure 21. Transient Thermal Impedance of Diode

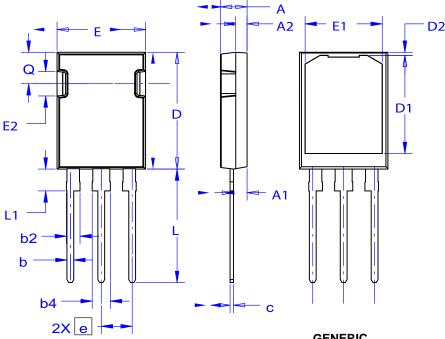


TO-247-3LD CASE 340CD ISSUE A

DATE 18 SEP 2018

NOTES:

- A. THIS PACKAGE DOES NOT CONFORM TO ANY STANDARDS.
- B. ALL DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR PROTRUSIONS.
- D. DIMENSION AND TOLERANCE AS PER ASME Y14.5-2009.



DIM	MILLIMETERS					
DIM	MIN	NOM	MAX			
Α	4.58	4.70	4.82			
A 1	2.20	2.40	2.60			
A2	1.80	2.00	2.20			
D	20.32	20.57	20.82			
Е	15.37	15.62	15.87			
E2	4.12	4.32	4.52			
е	~	5.45	~			
L	19.90	20.00	20.10			
L1	3.69	3.81	3.93			
Q	5.34	5.46	5.58			
b	1.10	1.20	1.30			
b2	2.10	2.24	2.39			
b4	2.87	3.04	3.20			
С	0.51	0.61	0.71			
D1	16.63	16.83	17.03			
D2	0.51	0.93	1.35			
E1	13.40	13.60	13.80			

GENERIC MARKING DIAGRAM*

XXXXXXXX AYWWG

XXXX = Specific Device Code

A = Assembly Location

Y = Year WW = Work Week G = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

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